

Joint ICTP-IAEA Workshop on "Advanced Ion Beam Techniques: Imaging and Characterisation with MeV ions" | (smr 2488)

Contribution ID : 1

Type : **not specified**

Ion Beam Analysis techniques (general overview of the techniques)

Monday, 30 September 2013 11:00 (1:00)

Content

Summary

Primary author(s) : ROGER WEBB (University of Surrey, UK)

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Session Classification : Ion Beam Analysis techniques (general overview of the techniques)